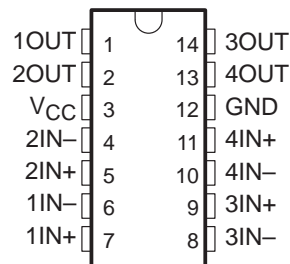


LM3302 QUADRUPLE DIFFERENTIAL COMPARATOR

SLCS014 –OCTOBER 1977 –REVISED APRIL 1988

- Single Supply or Dual Supplies
- Wide Range of Supply Voltage
2 V to 28 V
- Low Supply Current Drain Independent of Supply Voltage . . . 0.8 mA Typ
- Low Input Bias Current . . . 25 nA Typ
- Low Input Offset Current . . . 3 nA Typ
- Low Input Offset Voltage . . . 3 mV Typ
- Common-Mode Input Voltage Range Includes Ground
- Differential Input Voltage Range Equal to Maximum-Rated Supply Voltage . . . ± 28 V
- Low Output Saturation Voltage
- Output Compatible With TTL, MOS, and CMOS

D, J, OR N PACKAGE
(TOP VIEW)



description

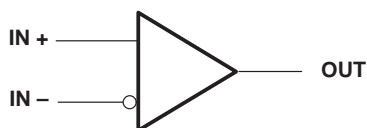
This device consists of four independent voltage comparators that are designed to operate from a single power supply over a wide range of voltages. Operation from dual supplies is also possible so long as the difference between the two supplies is 2 V to 28 V and V_{CC} is a least 1.5 V more positive than the input common-mode voltage. Current drain is independent of the supply voltage. The outputs can be connected to other open-collector outputs to achieve wired-AND relationships.

AVAILABLE OPTIONS

| T _A | V _{IO} max at 25°C | PACKAGE | | |
|----------------|-----------------------------|-----------------------------------|--------------------|--------------------|
| | | SMALL OUTLINE (D) [†] | CERAMIC DIP (J) | PLASTIC DIP (N) |
| -40°C to 85°C | 20 mV | LM3302D | LM3302J | LM3302N |

[†] The D packages are available taped and reeled. Add the suffix R to the device type, when ordering (i.e., LM3302DR).

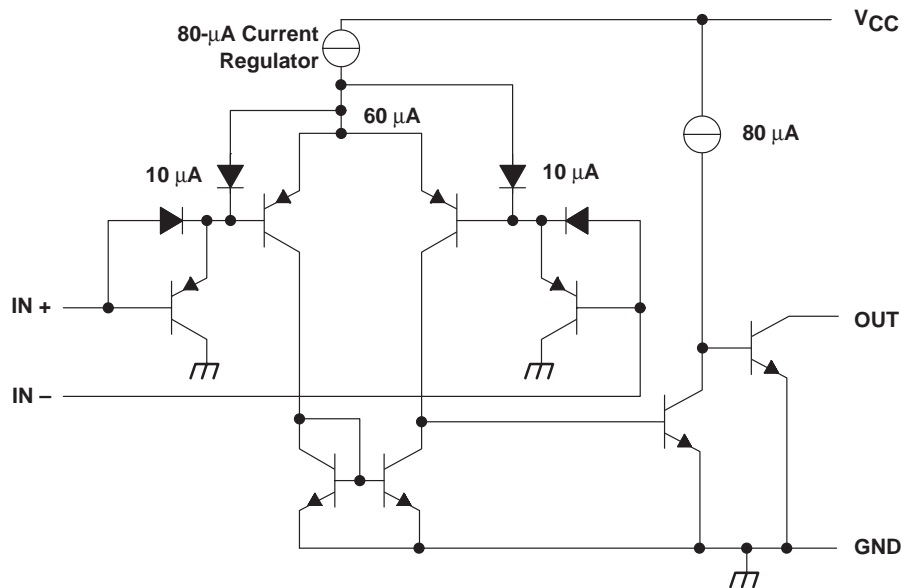
symbol (each comparator)



LM3302
QUADRUPLE DIFFERENTIAL COMPARATOR

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schematic



Current values shown are nominal.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

| | |
|--|------------------------------|
| Supply voltage, V_{CC} (see Note 1) | 28 V |
| Differential input voltage, V_{ID} (see Note 2) | ± 28 V |
| Input voltage range, V_I (either input), V_I | - 0.3 V to 28 V |
| Output voltage, V_O | 28 V |
| Output current, I_O | 20 mA |
| Duration of output short-circuit to ground (see Note 3) | unlimited |
| Continuous total dissipation | See Dissipation Rating Table |
| Operating free-air temperature range, T_A | - 40°C to 85°C |
| Storage temperature range | - 65°C to 150°C |
| Lead temperature range 1,6 mm (1/16 inch) from case for 60 seconds: J package | 300°C |
| Lead temperature range 1,6 mm (1/16 inch) from case for 10 seconds: D or N package | 260°C |

[†] Stresses beyond those listed under absolute maximum ratings may cause permanent damage to the device. There are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the recommended operating conditions section of this specification is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES:
1. All voltage values, except differential voltages, are with respect to the network ground.
 2. Differential voltages are at IN+ with respect to IN-.
 3. Short circuits from the output to V_{CC} can cause excessive heating and eventual destruction.

DISSIPATION RATING TABLE

| PACKAGE | $T_A \leq 25^\circ\text{C}$ POWER RATING | DERATING FACTOR ABOVE $T_A = 25^\circ\text{C}$ | $T_A = 70^\circ\text{C}$ POWER RATING | $T_A = 85^\circ\text{C}$ POWER RATING |
|---------|---|---|--|--|
| D | 950 mW | 7.6 mW/°C | 608 mW | 494 mW |
| J | 1025 mW | 8.2 mW/°C | 656 mW | 533 mW |
| N | 1150 mW | 9.2 mW/°C | 736 mW | 598 mW |

LM3302

QUADRUPLE DIFFERENTIAL COMPARATOR

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electrical characteristics at specified free-air temperature, $V_{CC} = 5\text{ V}$ (unless otherwise noted)

| PARAMETER | TEST CONDITIONS† | T_A | MIN | TYP | MAX | UNIT |
|--|---|----------------|-----|---------------------|-------|---------------|
| V_{IO} Input offset voltage | $V_{CC} = 5\text{ V to } 28\text{ V}, V_{IC} = V_{ICR} \text{ min}, V_O = 1.4\text{ V}$ | 25°C | | 3 | 20 | mV |
| | | – 40°C to 85°C | | | 40 | |
| I_{IO} Input offset current | $V_O = 1.4\text{ V}$ | 25°C | | 3 | 100 | nA |
| | | – 40°C to 85°C | | | 300 | |
| I_{IB} Input bias current | | 25°C | | – 25 | – 500 | nA |
| | | – 40°C to 85°C | | | –1000 | |
| V_{ICR} Common-mode input voltage range | | 25°C | | 0 to $V_{CC} - 1.5$ | | V |
| | | – 40°C to 85°C | | 0 to $V_{CC} - 2$ | | |
| A_{VD} Large-signal differential voltage amplification | $V_{CC} = 15\text{ V}, V_O = 1.4\text{ V to } 11.4\text{ V}, R_L = 15\text{ }\Omega \text{ to } V_{CC}$ | 25°C | | 2 | 30 | V/mV |
| I_{OH} High-level output current | $V_{ID} = 1\text{ V}, V_{OH} = 5\text{ V}$ | 25°C | | 0.1 | | nA |
| | | – 40°C to 85°C | | | 1 | μA |
| V_{OL} Low-level output voltage | $V_{ID} = 1\text{ V}, V_{OH} = 5\text{ V}$ | 25°C | | 150 | 500 | mV |
| | | – 40°C to 85°C | | | 700 | |
| I_{OL} Low-level output current | $V_{ID} = 1\text{ V}, V_{OL} = 1.5\text{ V}$ | 25°C | | 6 | 16 | mA |
| I_{CC} Supply current (four comparators) | $V_O = 2.5\text{ V}, \text{ No load}$ | 25°C | | 0.8 | | mA |

† All characteristics are measured with zero common-mode input voltage unless otherwise specified.

switching characteristics, $V_{CC} = 5\text{ V}, T_A = 25^\circ\text{C}$

| PARAMETER | TEST CONDITIONS | | MIN | TYP | MAX | UNIT |
|---------------|---|---------------------------|---------------------------------------|-----|-----|------|
| Response time | R _L = 5.1 kΩ to 5 V, See Note 4 | C _L = 15 pF †, | 100-mV input step with 5-mV overdrive | | 1.3 | μs |
| | | | TTL-level input step | | 0.3 | |

† C_L includes probe and jig capacitance.

NOTE 4: The response time specified is the interval between the input step function and the instant when the output crosses 1.4 V.



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